

/B and /R Flows

/B: Devices are processed to MIL STD 883 for class B devices which includes screening to test method 5004 including burn-in and 10090 electrical testing across the full operating temperature range (/B only) and QCI per test method 5005 (Groups A, B, C and D). Processing to MIL-STD-883 would be performed, but devices are non-compliant.

/R: Devices are processed to MIL STD 883 test method 5004 screening including burn in. Processing includes 5004 screening and Group A sample. (/R devices do not receive QCI for groups B, C and D).



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Worldwide Corporate Headquarters
16 Malcolm Hoyt Drive
Newburyport, MA 01950 USA

phone: 978.462.9332
fax: 978.462.9512
email: sales@rocelec.com

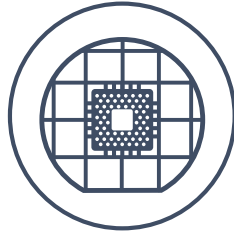


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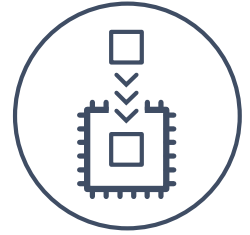
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